



FQT1N80TF_WS N-Channel MOSFET 800V, 0.2A, 20Ω

Features

- $R_{DS(on)} = 15.5\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 0.1A$
- Low gate charge (Typ. 5.5nC)
- Low Crss (Typ. 2.7pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS compliant

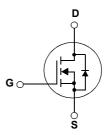


Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

	<u> </u>	<u> </u>			
Symbol		Parameter		FQT1N80TF_WS	Units
V _{DSS}	Drain to Source Voltage			800	V
V _{GSS}	Gate to Source Voltage			±30	V
ı	Drain Current	-Continuous (T _C = 25°C)		0.2	Α.
ID	DrainGurient	-Continuous (T _C = 100°C)		0.12	Α
I _{DM}	Drain Current	- Pulsed	(Note 1)	0.8	Α
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	90	mJ
I _{AR}	Avalanche Current		(Note 1)	0.2	Α
E _{AR}	Repetitive Avalanche Energ	у	(Note 1)	0.2	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.0	V/ns
n	Dawer Discination	(T _C = 25°C)		2.1	W
P_{D}	Power Dissipation	- Derate above 25°C		0.02	W/°C
T _J , T _{STG}	Operating and Storage Tem	perature Range		-55 to +150	°C
TL	Maximum Lead Temperature 1/8" from Case for 5 Secon	Maximum Lead Temperature for Soldering Purpose,			°C

Thermal Characteristics

Symbol	Parameter	Min.	Max.	Units
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient*	-	60	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information T_C = 25°C unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FQT1N80	FQT1N80TF_WS	SOT-223	330mm	12mm	4000

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0 V$, $T_J = 25 ^{\circ} C$	800	-	-	V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.8	-	V/°C
	Zoro Coto Voltago Droin Current	V _{DS} = 800V, V _{GS} = 0V	-	-	25	^
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 640V, T_C = 125^{\circ}C$	-	-	250	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 0.1A$		15.5	20	Ω
g _{FS}	Forward Transconductance	$V_{DS} = 40V, I_D = 0.1A$ (Note 4)	-	0.75	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V		-	150	195	pF
C _{oss}	Output Capacitance	V _{DS} = 25V, V _{GS} = 0V f = 1MHz	,	-	20	30	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	İ	-	2.7	5.0	pF
Q_g	Total Gate Charge at 10V			-	5.5	7.2	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 640V, I_{D} = 1A$		-	1.1	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V	(Note 4, 5)	-	3.3	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	10	30	ns
t _r	Turn-On Rise Time	$V_{DD} = 400V, I_{D} = 1A$	-	25	60	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$	-	15	40	ns
t _f	Turn-Off Fall Time	(Note 4, 5)	-	25	60	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	0.2	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	0.8	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 0.2A$	-	-	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 1A	-	300	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (Note	4) -	0.6	-	μС

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 170mH, I_{AS} = 1A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
- 3. I $_{SD} \leq$ 1A, di/dt \leq 200A/µs, V $_{DD} \leq$ BV $_{DSS},$ Starting T $_{J}$ = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s,$ Duty Cycle $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

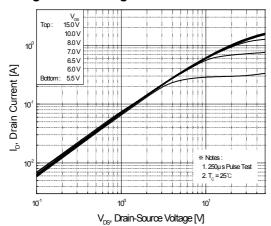


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

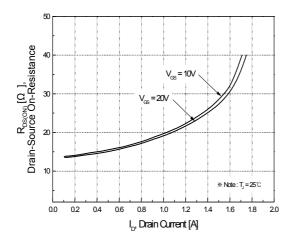


Figure 5. Capacitance Characteristics

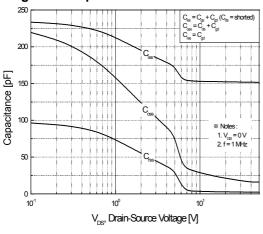


Figure 2. Transfer Characteristics

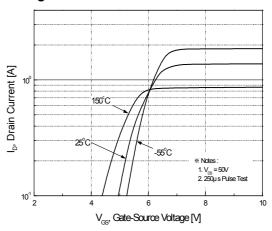


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

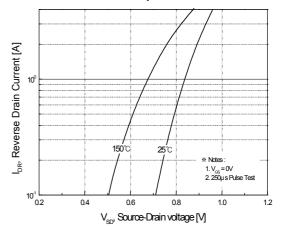
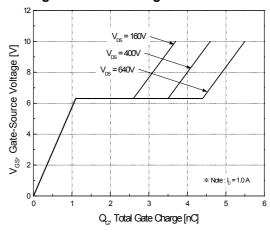


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

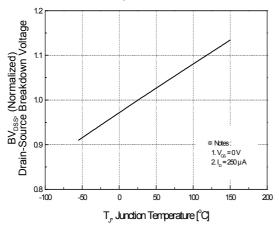


Figure 8. On-Resistance Variation vs. Temperature

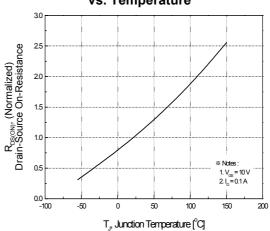


Figure 9. Maximum Safe Operating Area

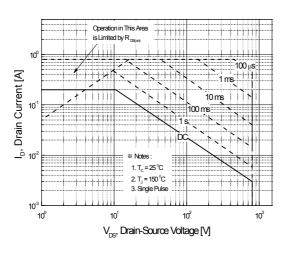


Figure 10. Maximum Drain Current vs. Case Temperature

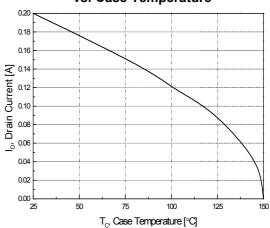
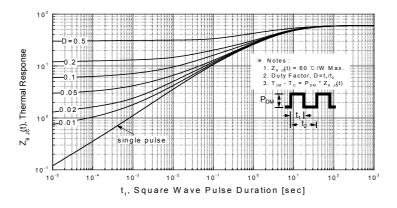
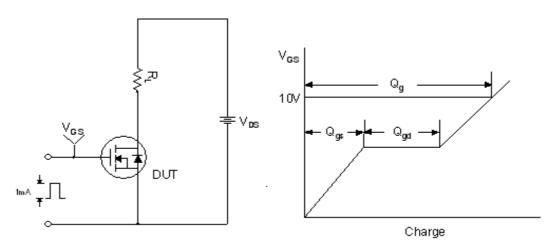


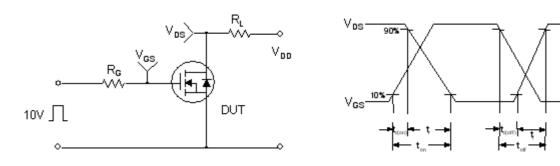
Figure 11. Transient Thermal Response Curve



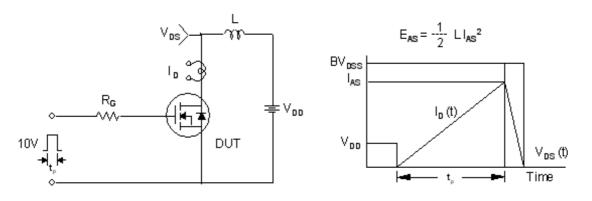
Gate Charge Test Circuit & Waveform



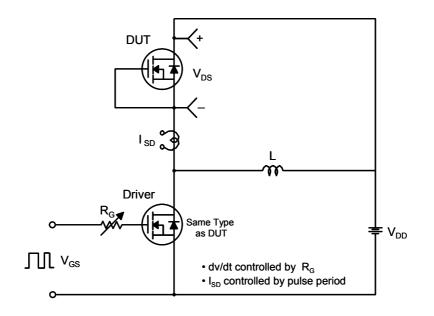
Resistive Switching Test Circuit & Waveforms

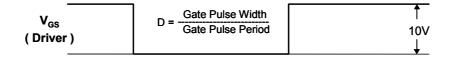


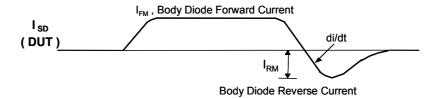
Unclamped Inductive Switching Test Circuit & Waveforms

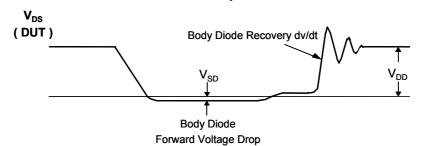


Peak Diode Recovery dv/dt Test Circuit & Waveforms



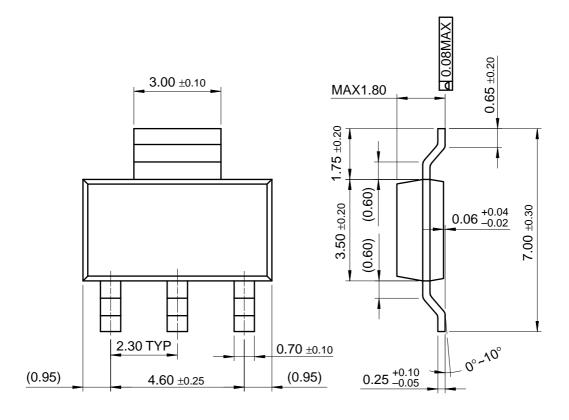


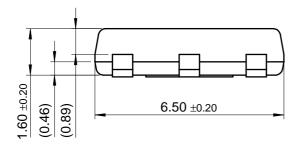




Mechanical Dimensions

SOT-223









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